

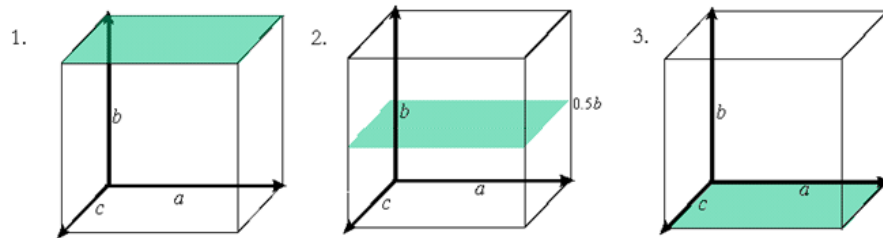
End-Sem Examination
Odd Semester - 2017-18
Semiconductor Devices and Circuits (SEMI)
B.Tech. (ECE) 2nd Year

Time: 3 Hrs

Total Marks: 50

All Questions are compulsory and Self-Explanatory.

Q1. Discuss all the steps to determine the Miller Indices of a plane. Also, determine the miller indices for the following planes: [2 + 3]



• Intercepts are $\infty, 1, \infty$

• Miller indices of the plane are:

$$\left(\frac{1}{\infty} \frac{1}{1} \frac{1}{\infty} \right) = (010)$$

• Intercepts are $\infty, 1/2, \infty$

• Miller indices of the plane are:

$$\left(\frac{1}{\infty} \frac{1}{1/2} \frac{1}{\infty} \right) = (020) = (010)$$

3 ---> 1

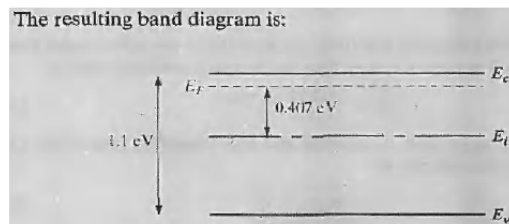
Q2. A Si sample is doped with 10^{17} As atoms/cm³. What is the equilibrium hole concentration p_0 at 300 K? Where is E_F relative to E_i ? For your calculation you can use $n_i = 1.5 \times 10^{10}$ cm⁻³, $kT = 0.0259$ eV. [2]

Since $N_d \gg n_i$, we can approximate $n_0 = N_d$ and

$$p_0 = \frac{n_i^2}{n_0} = \frac{2.25 \times 10^{20}}{10^{17}} = 2.25 \times 10^3 \text{ cm}^{-3}$$

$$E_F - E_i = kT \ln \frac{n_0}{n_i} = 0.0259 \ln \frac{10^{17}}{1.5 \times 10^{10}} = 0.407 \text{ eV}$$

The resulting band diagram is:

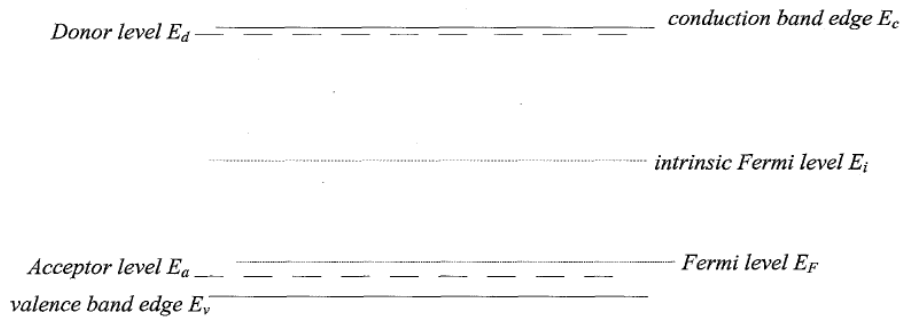


Q3. Define the Hall Effect in n-type semiconductor. How do we identify the type of a material with the help of the Hall Effect? List down the 4 applications of Hall Effect. [3 + 2 + 2]

You can refer to Hall Effect Slides

Q4. The equilibrium band diagram for a doped direct gap semiconductor is shown below. Is it n-type, p-type or not enough information provided? [1]

Ans: P type



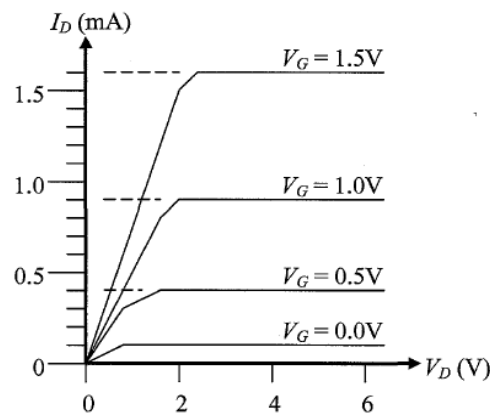
What if any of the following conditions by themselves could lead to the above band diagram?

Choose the correct answer from the following:

[1]

- a) Very high temperature
- b) Very high acceptor doping**
- c) Very low acceptor doping

Q5. Consider the following MOSFET characteristic:



- a) Is this an n-channel or p-channel device?

[1]

Ans: n-channel

- b) Does this appear to be a long-channel or short-channel device?

[1]

Ans: Long Channel

- c) What is the apparent threshold voltage V_T ?

[1]

- 0.5

- d) Is this a depletion mode or enhancement mode MOSFET?

[1]

depletion mode

Q6. (a) What is threshold voltage in MOSFET? Derive the *Threshold Voltage* equation for NMOS. Apply the substrate biasing V_{SB} to the derived equation and write down the final equation for the *Threshold Voltage*. [1 + 3 + 2]

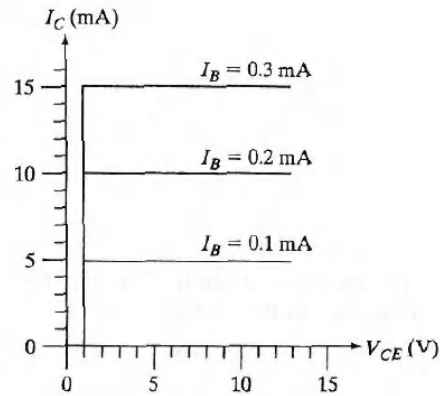
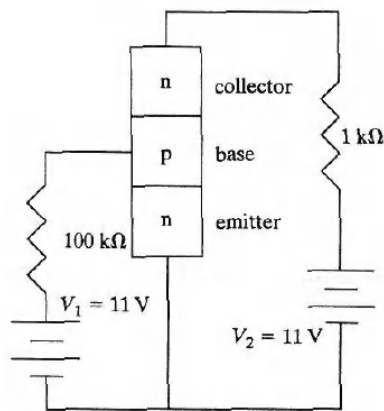
Ans: Threshold voltage definition and derivation you can refer to book.

(b) Calculate the threshold voltage V_{T0} at $V_{SB} = 0$, for a polysilicon gate n-channel MOS transistor, with the following parameters: substrate doping density $N_A = 10^{16} \text{ cm}^{-3}$, polysilicon gate doping density $N_D = 2 \times 10^{19} \text{ cm}^{-3}$, gate oxide thickness $t_{ox} = 50 \text{ nm}$ and oxide-interface fixed charge density $N_{ox} = 4 \times 10^{10} \text{ cm}^{-2}$. $kT/q = 0.026 \text{ eV}$, $n_i = 1.45 \times 10^{10} \text{ cm}^{-3}$, $\Phi_F(\text{gate}) = 0.55 \text{ V}$, $\epsilon_0 = 8.845 \times 10^{-14} \text{ Fcm}^{-1}$, $\epsilon_{si}/\epsilon_0 = 11.7$, $q = 1.6 \times 10^{-19} \text{ C}$

[4]

Ans: $V_{T0} = 0.40 \text{ V}$

Q7. Consider the following bipolar junction transistor (BJT) circuit and somewhat idealized transistor characteristics where, in particular, the voltage drop across the forward biased base-emitter junction is assumed to be constant and equal to 1 V for simplicity.



- a) What is the (common-emitter) gain β ? [2]
ans: 50
- b) Draw the load line on the transistor characteristics. [2]
 $V_{CE} = 0 \rightarrow I_C = 11 \text{ mA}$ $I_C = 0 \text{ mA} \rightarrow V_{CE} = 11 \text{ V}$
- c) What is the collector-emitter voltage drop in this circuit within half a volt? [2]

$$I_B \frac{(11-1)V}{100k\Omega} = 0.1 \text{ mA} \rightarrow V_{CE} = 6 \text{ V}$$
- d) If voltage V_i could be changed, what value of V_i would drive BJT in this circuit to the edge of saturation? [2]
 $I_B = 0.2 \text{ mA}$ at onset of saturation.

$$\frac{V_i - 1 \text{ V}}{100k\Omega} = 0.2 \text{ mA} \rightarrow V_i = 21 \text{ V}$$

Q8. Discuss the breakdown mechanisms in a lightly doped and heavily doped p-n junction under reverse biased condition. [2 + 2]

Ans: Lightly Doped --- Avalanche Breakdown and Heavily doped --- Zener Break down (discussion)

Q9. Write the short note one the followings: [2 + 2 + 2 + 2]

- | | |
|--|------------------------------------|
| (a) Channel Length Modulation | (b) Drain Induced Barrier Lowering |
| (c) Excess Charge Carriers in Semiconductors | (d) Continuity Equation |

For these ans you can refer to book